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Journal of Magnetism and Magnetic Materials 272–276 (2004) e1571–e1572

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Doping effect of indium oxide-based diluted magnetic semiconductor thin films

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Abstract

Transition metal (TM = Mn, Fe, and Co) doped $\text{In}_{2-x}\text{TM}_x\text{O}_3$ ($0.0 \leq x \leq 1.0$) nanostructure thin films have been successfully prepared by means of sol-gel process onto $\text{SiO}_2/\text{Si}(100)$, Corning 7059 glass and $\text{MgO}(100)$ substrates annealed at 600°C in oxygen atmosphere. Room temperature magnetic hysteresis curve showed a ferromagnetic behavior and this result clearly indicates that the $\text{In}_{2-x}\text{TM}_x\text{O}_3$ thin films are advantageous not only for practical application to magnetic device but also for physical basic studies on electro-magnetic properties of $\text{In}_{2-x}\text{TM}_x\text{O}_3$ films.

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PACS: 61.10.-i; 75.50.Pp; 76.80.+y

Keywords: Diluted magnetic semiconductor; Indium oxide; Sol-gel process
